

Notice of References Cited

Application/Control No.

10/559,831

Applicant(s)/Patent Under
Reexamination
YOO, WOONG-TUK

Examiner

MICHAEL VANCHY JR

Art Unit

2624

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,542,624 B1	04-2003	Oda, Takahiro	382/117
	B	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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